RADIO TEST REPORT

Test Report No. : 11496304H-A-R1

Applicant	:	**Murata Manufacturing Co., Ltd.**
Type of Equipment	:	**Communication Module**
Model No.	:	**Type1GR**
FCC ID	:	**VPYLB1GR**
Test regulation	:	**FCC Part 15 Subpart C: 2016**
Test Result	:	**Complied**

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11496304H-A.11496304H-A is replaced with this report.

Date of test: October 21 to 23, 2016

Representative test engineer:
K. Kawamura
Keisuke Kawamura
Engineer
Consumer Technology Division

Approved by:
Takayuki. S
Takayuki Shimada
Engineer
Consumer Technology Division

NVLAP TESTING
NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address,
http://japan.ul.com/resources/emc_accredited/

REVISION HISTORY

Original Test Report No.: 11496304H-A-R1

Revision	Test report No.	Date	Page revised	Contents
- (Original)	11496304H-A	November 14, 2016	-	-
1	11496304H-A-R1	November 29, 2016	P 9	Correction of explanatory note *1).
1	11496304H-A-R1	November 29, 2016	P 37	Replacement of photos.

UL Japan, Inc.
Ise EMC Lab.
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8999
Facsimile : +81 596 24 8124

CONTENTS **PAGE**

SECTION 1: Customer information

Company Name	:	Murata Manufacturing Co., Ltd.
Address	:	1-10-1 Higashikotari, Nagaokakyo-shi, Kyoto 617-8555 Japan
Telephone Number	:	+81-75-955-6736
Facsimile Number	:	+81-75-955-6634
Contact Person	:	Motoo Hayashi

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Communication Module
Model No.	:	Type1GR
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	VBAT: Typ. 1.8 V, Min. 1.65 V, Max. 1.95 V VIO*: Typ. 1.8 V, Min. 1.65 V, Max. 1.95 V *This doesn't influence the RF Characteristic.
Receipt Date of Sample	:	October 21, 2016
Country of Mass-production	:	China
Condition of EUT	:	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model: Type1GR (referred to as the EUT in this report) is a Communication Module.

General Specification

Clock frequency(ies) in the system	:	24 MHz, 32.768kHz (Crystal)
Operating temperature	:	-20 deg. C to +85 deg. C (Typ: +25 deg. C)

Radio Specification

Equipment Type	Transceiver
Frequency of Operation	2402 MHz - 2480 MHz
Type of Modulation	GFSK
Bandwidth & Channel spacing	2 MHz & 2 MHz
Method of frequency generation	Synthesizer
Power Supply (inner)	DC 1.2 V
Antenna Type	Monopole Pattern Antenna
Antenna Gain	-0.2 dBi

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification	:	FCC Part 15 Subpart C FCC Part 15 final revised on November 14, 2016 and effective December 14, 2016
Title	:	FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz

* The revision on November 14, 2016, does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	**FCC:** ANSI C63.10-2013 6. Standard test methods **IC:** RSS-Gen 8.8	**FCC:** Section 15.207 **IC:** RSS-Gen 8.8	**QP** 33.9 dB, 0.15000 MHz, N **AV** 37.5 dB, 0.46900 MHz, N 0.47190 MHz, L	Complied	-
6dB Bandwidth	**FCC:** KDB 558074 D01 DTS Meas Guidance v03r05 **IC:** -	**FCC:** Section 15.247(a)(2) **IC:** RSS-247 5.2(1)	See data.	Complied	Conducted
Maximum Peak Output Power	**FCC:** KDB 558074 D01 DTS Meas Guidance v03r05 **IC:** RSS-Gen 6.12	**FCC:** Section 15.247(b)(3) **IC:** RSS-247 5.4(4)		Complied	Conducted
Power Density	**FCC:** KDB 558074 D01 DTS Meas Guidance v03r05 **IC:** -	**FCC:** Section 15.247(e) **IC:** RSS-247 5.2(2)		Complied	Conducted
Spurious Emission Restricted Band Edges	**FCC:** KDB 558074 D01 DTS Meas Guidance v03r05 **IC:** RSS-Gen 6.13	**FCC:** Section15.247(d) **IC:** RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	17.1 dB 2483.500 MHz, AV, Vertical	Complied	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *1)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.
*1) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 DTS Meas Guidance v03r05 12.2.7.

* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

The RF Module has its own regulator.
The RF Module is constantly provided voltage (DC 1.2 V) through the regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	**IC:** RSS-Gen 6.6	**IC:** -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

Ise EMC Lab.

Antenna terminal test Uncertainty (+/-)							
Power meter		Conducted emission and Power density			Conducted emission		Channel power
Below 1 GHz	Above 1 GHz	Below 1 GHz	1 GHz -3 GHz	3 GHz -18 GHz	18 GHz -26.5 GHz	26.5 GHz -40 GHz	
0.9 dB	1.0 dB	1.4 dB	1.7 dB	2.8 dB	2.8 dB	2.9 dB	2.6 dB

Frequency range	Conducted emission using AMN(LISN) (+/-)
0.009 – 0.15MHz	3.5 dB
0.15 – 30MHz	3.0 dB

Test distance	Radiated emission (+/-) 9 kHz - 30 MHz
3m	3.8 dB
10m	3.7 dB

Polarity	Radiated emission (Below 1GHz)			
	(3 m*) (+/-)		(10 m*) (+/-)	
	30 – 200 MHz	200 – 1000MHz	30 – 200 MHz	200 – 1000MHz
Horizontal	5.0 dB	5.3 dB	5.0 dB	5.0 dB
Vertical	4.7 dB	5.9 dB	5.0 dB	5.1 dB

Radiated emission (Above 1GHz)				
(3 m*) (+/-)		(1 m*) (+/-)		(10 m*) (+/-)
1 – 6GHz	6 – 18GHz	10 – 26.5 GHz	26.5 – 40GHz	1 -18 GHz
5.2 dB	5.4 dB	5.5 dB	5.5 dB	5.4 dB

*Measurement distance

Conducted Emission test
The data listed in this test report has enough margin, more than the site margin.

Radiated emission test
The data listed in this test report has enough margin, more than the site margin.

3.5 Test Location

UL Japan, Inc. Ise EMC Lab. *NVLAP Lab. code: 200572-0
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone: +81 596 24 8999, Facsimile: +81 596 24 8124

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	N/A	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

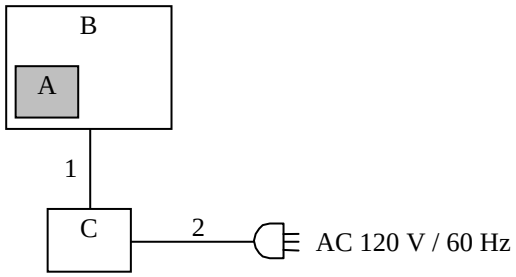
4.1 Operating Mode(s)

Bluetooth (BT) Low Energy (LE) : Transmitting (Tx)

*The details of Operating mode(s)

Test Item	Operating Mode	Tested frequency
Conducted Emission Spurious Emission 6dB Bandwidth Maximum Peak Output Power Power Density 99% Occupied Bandwidth	BT LE	2402 MHz 2440 MHz 2480 MHz
*Power of the EUT was set by the software as follows; Power settings: 2.5 dBm Software: SDK-2.2.3 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.		

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Communication Module	Type1GR	No.1 for CE/RE No.2 for AT	Murata Manufacturing Co., Ltd.	EUT
B	Jig Board	-	-	-	*1)
C	DC Power Supply	PMC35-2A	13090501	KIKUSUI	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	0.5 for CE* 2.5 for RE and AT	Unshielded	Unshielded	-
2	AC Cable	1.8	Unshielded	Unshielded	-

*1) The test was performed with the module that as normal assumed implementation conditions
This module was installed on the JIG board that had not ground pattern on the antenna mounted places of module.

CE : Conducted Emission.
RE : Radiated Emission.
AT : Antenna Terminal Conducted.

SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.
The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)
I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.
The EUT was connected to a LISN (AMN).
An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	**: QP and CISPR AV**
Measurement range	**: 0.15 MHz - 30 MHz**
Test data	**: APPENDIX**
Test result	**: Pass**

SECTION 6: Radiated Spurious Emission

Test Procedure

It was measured based on "11.0 Emissions in non-restricted frequency bands" of "558074 D01 DTS Meas Guidance v03r05".

[For below 1 GHz]
EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]
EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.
The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.
The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.
The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).
The test was made with the detector (RBW/VBW) in the following table.
When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(IC) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (IC).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV *3)	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	Average Power Method: RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces If duty cycle was less than 98%, a duty factor was added to the results.	RBW: 100 kHz VBW: 300 kHz
Test Distance	3 m	3.75 m *1) (1 GHz – 10 GHz), 1.0 m *2) (10 GHz – 26.5 GHz)		3.75 m *1) (1 GHz – 10 GHz), 1.0 m *2) (10 GHz – 26.5 GHz)

*1) Distance Factor: 20 x log (3.75 m / 3.0 m) = 1.94 dB
*2) Distance Factor: 20 x log (1.0 m / 3.0 m) = -9.5 dB
*3) Average Power Measurement was performed based on 6. 0 & 12.2.5 of "KDB 558074 D01 DTS Meas Guidance v03r05"

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30 MHz - 26.5 GHz
Test data : APPENDIX
Test result : Pass

SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	2 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/ Average *2)	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	10 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *3)
Conducted Spurious Emission *4)	9kHz to 150kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	9.1 kHz	27 kHz				

*1) Peak hold was applied as Worst-case measurement.
*2) Reference data
*3) Section 10.2 Method PKPSD (peak PSD) of "KDB 558074 D01 DTS Meas Guidance v03r05".
*4) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.
Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.
(9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 9.1 kHz)

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX
Test result : Pass

APPENDIX 1: Test data

Conducted Emission

DATA OF CONDUCTED EMISSION TEST

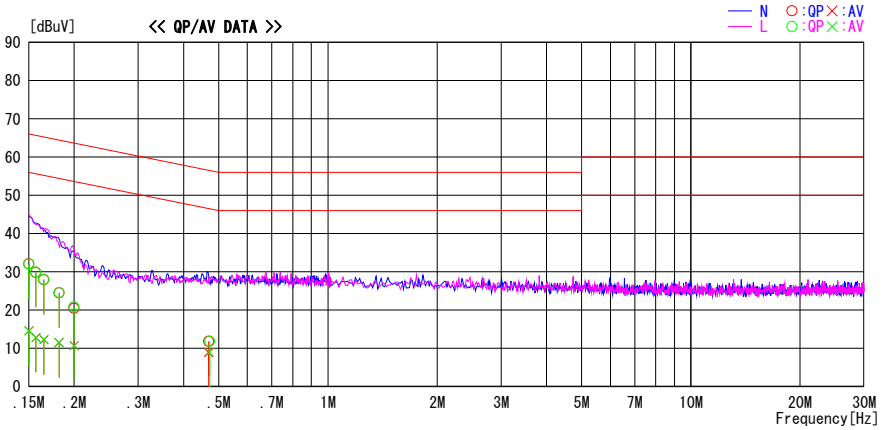
UL Japan, Inc. Ise EMC Lab. No.3 Semi Anechoic Chamber
Date : 2016/10/23

Report No. : 11496304H

Temp./Humi. : 23deg. C / 64% RH
Engineer : Tomoki Matsui

Mode / Remarks : Tx BTLE 2480MHz

LIMIT : FCC15.207 QP
FCC15.207 AV



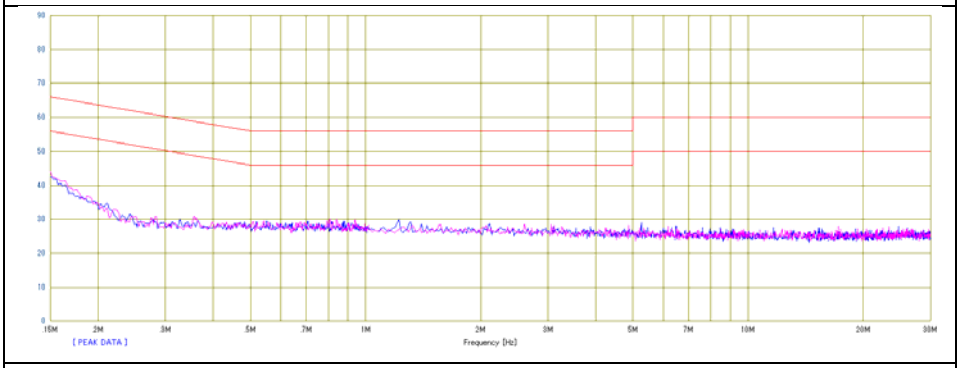
Frequency	Reading Level		Corr.	Results		Limit		Margin		Phase	Comment
	QP	AV	Factor	QP	AV	QP	AV	QP	AV		
[MHz]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
0.15000	18.9	1.4	13.2	32.1	14.6	66.0	56.0	33.9	41.4	N	
0.15000	18.8	1.4	13.2	32.0	14.6	66.0	56.0	34.0	41.4	L	
0.15680	16.6	-0.4	13.2	29.8	12.8	65.6	55.6	35.8	42.8	N	
0.16500	14.7	-1.0	13.2	27.9	12.2	65.2	55.2	37.3	43.0	N	
0.18150	11.3	-1.7	13.2	24.5	11.5	64.4	54.4	39.9	42.9	N	
0.15680	16.7	-0.4	13.2	29.9	12.8	65.6	55.6	35.7	42.8	L	
0.20000	7.3	-2.5	13.2	20.5	10.7	63.6	53.6	43.1	42.9	N	
0.16500	14.8	-0.9	13.2	28.0	12.3	65.2	55.2	37.2	42.9	L	
0.18150	11.4	-1.7	13.2	24.6	11.5	64.4	54.4	39.8	42.9	L	
0.20000	7.6	-2.5	13.2	20.8	10.7	63.6	53.6	42.8	42.9	L	
0.46900	-1.5	-4.3	13.3	11.8	9.0	56.5	46.5	44.7	37.5	N	
0.47190	-1.5	-4.3	13.3	11.8	9.0	56.5	46.5	44.7	37.5	L	

CHART : WITH FACTOR, Peak hold data. CALCULATION : RESULT = READING + C.F (LISN + ATTEN + CABLE)
Except for the above table : adequate margin data below the limits.

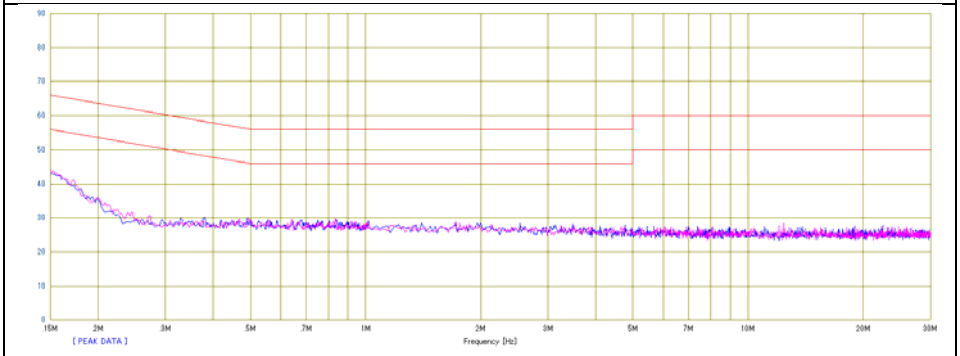
Conducted Emission

Test place	Ise EMC Lab. No.3 Semi Anechoic Chamber
Report No.	11496304H
Date	October 23, 2016
Temperature / Humidity	23 deg. C / 64 % RH
Engineer	Tomoki Matsui
Mode	Tx BT LE

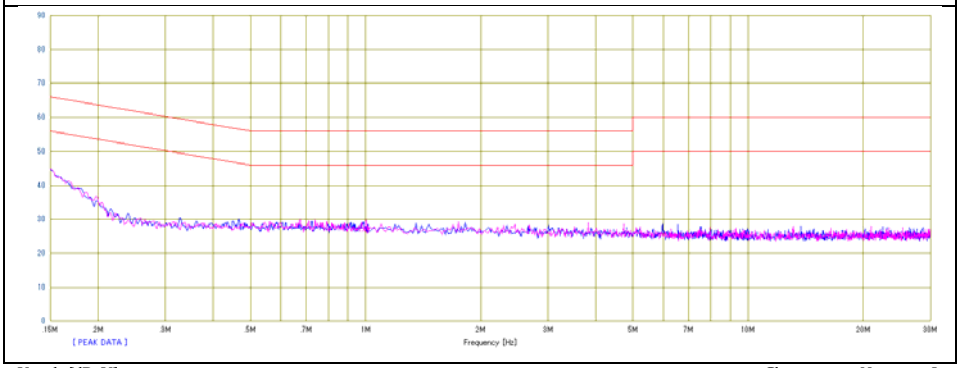
2402 MHz



2440 MHz



2480 MHz



Y scale [dBuV] Chart — N — L

6dB Bandwidth

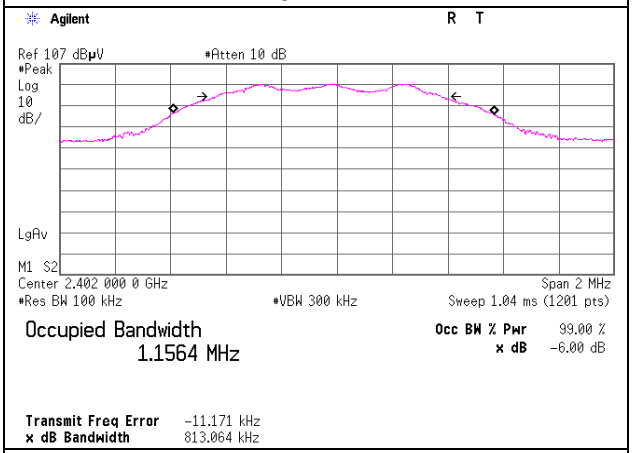
Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE

Mode	Frequency [MHz]	6dB Bandwidth [MHz]	Limit [kHz]
BT LE	2402	0.813	> 500
	2440	0.813	> 500
	2480	0.807	> 500

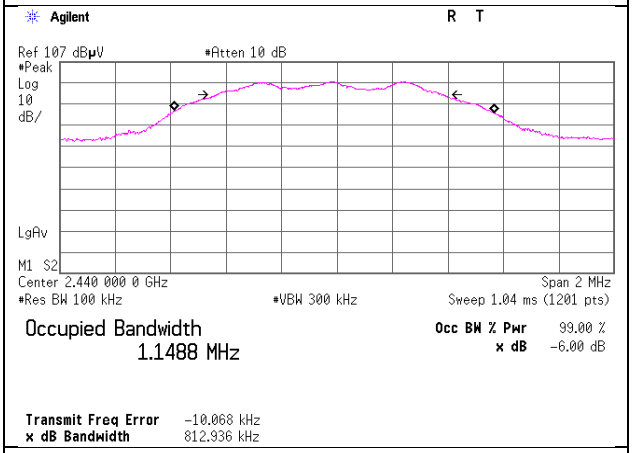
6dB Bandwidth

BT LE

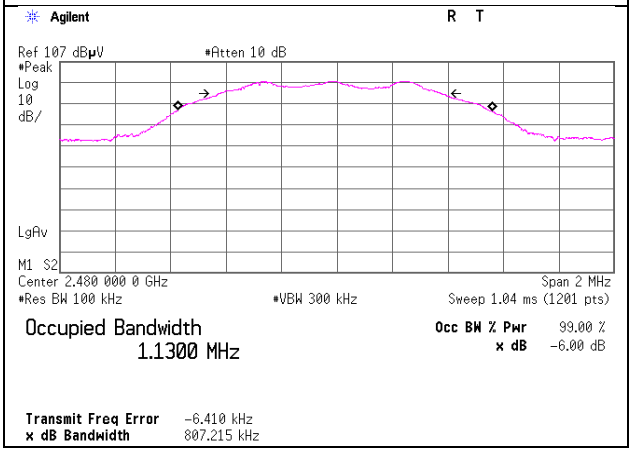
2402 MHz



2440 MHz



2480 MHz



Maximum Peak Output Power

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE

Freq.	Reading	Cable Loss	Atten. Loss	Result		Limit		Margin
[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
2402	-8.91	1.22	10.09	2.40	1.74	30.00	1000	27.60
2440	-8.86	1.23	10.09	2.46	1.76	30.00	1000	27.54
2480	-8.65	1.24	10.09	2.68	1.85	30.00	1000	27.32

Sample Calculation:
Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

Average Output Power
(Reference data for RF Exposure)

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE

Freq.	Reading	Cable Loss	Atten. Loss	Result (Time average)		Duty	Result Burst power average	
[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dB]	[dBm]	[mW]
2402	-11.05	1.22	10.09	0.26	1.06	1.19	1.45	1.40
2440	-11.00	1.23	10.09	0.32	1.08	1.19	1.51	1.42
2480	-10.79	1.24	10.09	0.54	1.13	1.19	1.73	1.49

Sample Calculation:
Result (Time average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss
Result (Burst power average) = Time average + Duty factor

Burst rate confirmation

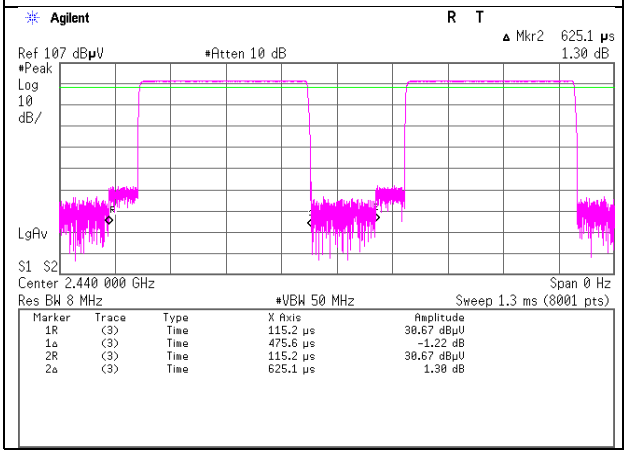
Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE

BT LE

Tx on / (Tx on + Tx off) = 0.761

Tx on / (Tx on + Tx off) * 100 = 76.1 %

Duty factor = 10 * log (0.6251 / 0.4756) = 1.19 dB



Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.2
Report No.	11496304H	
Date	October 22, 2016	October 23, 2016
Temperature / Humidity	23 deg. C / 64 % RH	23 deg. C / 50 % RH
Engineer	Tomoki Matsui	Koji Yamamoto
	(Below 1 GHz and Above 10 GHz)	(1 GHz - 10 GHz)
Mode	Tx BT LE 2402 MHz	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	50.000	QP	22.9	10.3	7.4	32.2	-	8.4	40.0	31.6	
Hori	80.000	QP	22.6	6.3	7.8	32.2	-	4.5	40.0	35.5	
Hori	150.000	QP	22.2	14.8	8.6	32.1	-	13.5	43.5	30.0	
Hori	250.000	QP	22.0	12.5	9.5	32.0	-	12.0	46.0	34.0	
Hori	550.000	QP	22.0	18.4	11.6	32.0	-	20.0	46.0	26.0	
Hori	800.000	QP	21.9	20.8	13.0	31.5	-	24.2	46.0	21.8	
Hori	2390.000	PK	43.8	27.6	4.9	34.8	-	41.5	73.9	32.4	
Hori	4804.000	PK	42.7	31.5	6.5	34.1	-	46.6	73.9	27.3	Floor noise
Hori	7206.000	PK	43.1	36.1	7.7	34.1	-	52.8	73.9	21.1	Floor noise
Hori	9608.000	PK	44.2	38.5	8.5	34.8	-	56.4	73.9	17.5	Floor noise
Hori	2390.000	AV	33.1	27.6	4.9	34.8	1.2	32.0	53.9	21.9	*1)
Hori	4804.000	AV	34.2	31.5	6.5	34.1	-	38.1	53.9	15.8	Floor noise
Hori	7206.000	AV	33.3	36.1	7.7	34.1	-	43.0	53.9	10.9	Floor noise
Hori	9608.000	AV	34.2	38.5	8.5	34.8	-	46.4	53.9	7.5	Floor noise
Vert	50.000	QP	22.9	10.3	7.4	32.2	-	8.4	40.0	31.6	
Vert	80.000	QP	22.6	6.3	7.8	32.2	-	4.5	40.0	35.5	
Vert	150.000	QP	22.2	14.8	8.6	32.1	-	13.5	43.5	30.0	
Vert	250.000	QP	22.0	12.5	9.5	32.0	-	12.0	46.0	34.0	
Vert	550.000	QP	22.0	18.4	11.6	32.0	-	20.0	46.0	26.0	
Vert	800.000	QP	21.9	20.8	13.0	31.5	-	24.2	46.0	21.8	
Vert	2390.000	PK	43.7	27.6	4.9	34.8	-	41.4	73.9	32.5	
Vert	4804.000	PK	42.9	31.5	6.5	34.1	-	46.8	73.9	27.1	Floor noise
Vert	7206.000	PK	43.3	36.1	7.7	34.1	-	53.0	73.9	20.9	Floor noise
Vert	9608.000	PK	43.9	38.5	8.5	34.8	-	56.1	73.9	17.8	Floor noise
Vert	2390.000	AV	35.5	27.6	4.9	34.8	1.2	34.4	53.9	19.5	*1)
Vert	4804.000	AV	32.4	31.5	6.5	34.1	-	36.3	53.9	17.6	Floor noise
Vert	7206.000	AV	33.0	36.1	7.7	34.1	-	42.7	53.9	11.2	Floor noise
Vert	9608.000	AV	35.4	38.5	8.5	34.8	-	47.6	53.9	6.3	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.75 m / 3.0 m) = 1.94 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

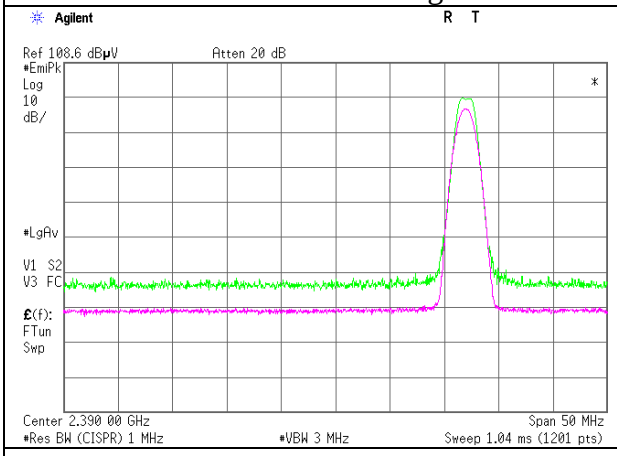
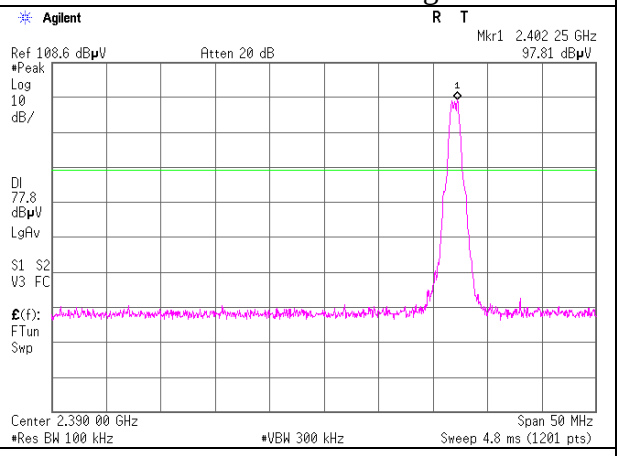
20dBc Data Sheet

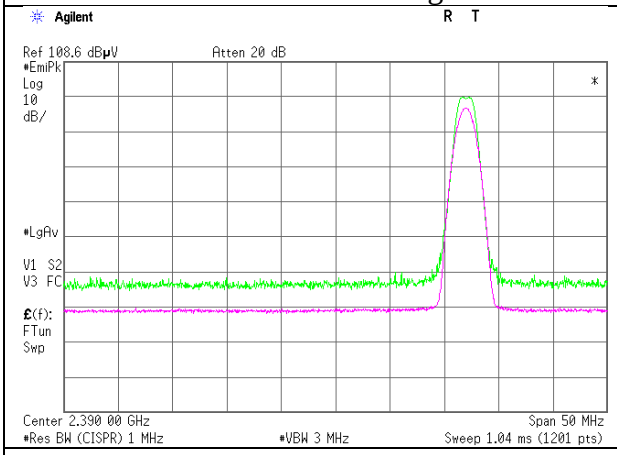
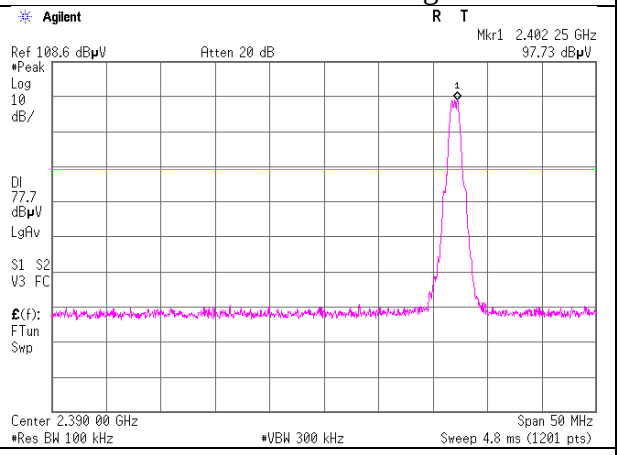
Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	2402.000	PK	97.8	27.6	5.0	34.8	95.6	-	-	Carrier
Hori	2400.000	PK	46.1	27.6	5.0	34.8	43.9	75.6	31.7	
Vert	2402.000	PK	97.7	27.6	5.0	34.8	95.5	-	-	Carrier
Vert	2400.000	PK	45.5	27.6	5.0	34.8	43.3	75.5	32.2	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amprifier)

Radiated Spurious Emission
(Reference Plot for band-edge)

Test place	Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No.	11496304H
Date	October 23, 2016
Temperature / Humidity	23 deg. C / 50 % RH
Engineer	Koji Yamamoto
	(1 GHz - 10 GHz)
Mode	Tx BT LE 2402 MHz

Horizontal	
Restricted-band band-edge Plot	Authorized-band band-edge Plot
	
Trace Green : Peak Plot Trace Purple : Average Plot	20dBc Plot

Vertical	
Restricted-band band-edge Plot	Authorized-band band-edge Plot
	
Trace Green : Peak Plot Trace Purple : Average Plot	20dBc Plot

* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.2
Report No.	11496304H	
Date	October 22, 2016	October 23, 2016
Temperature / Humidity	23 deg. C / 64 % RH	23 deg. C / 50 % RH
Engineer	Tomoki Matsui	Koji Yamamoto
	(Below 1 GHz and Above 10 GHz)	(1 GHz - 10 GHz)
Mode	Tx BT LE 2440 MHz	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	50.000	QP	22.9	10.3	7.4	32.2	-	8.4	40.0	31.6	
Hori	80.000	QP	22.6	6.3	7.8	32.2	-	4.5	40.0	35.5	
Hori	150.000	QP	22.2	14.8	8.6	32.1	-	13.5	43.5	30.0	
Hori	250.000	QP	22.0	12.5	9.5	32.0	-	12.0	46.0	34.0	
Hori	550.000	QP	22.0	18.4	11.6	32.0	-	20.0	46.0	26.0	
Hori	800.000	QP	21.9	20.8	13.0	31.5	-	24.2	46.0	21.8	
Hori	4880.000	PK	42.7	31.7	6.5	34.1	-	46.8	73.9	27.1	Floor noise
Hori	7320.000	PK	40.8	36.3	7.8	34.1	-	50.8	73.9	23.1	Floor noise
Hori	9760.000	PK	42.3	38.5	8.6	34.8	-	54.6	73.9	19.3	Floor noise
Hori	4880.000	AV	33.1	31.7	6.5	34.1	-	37.2	53.9	16.7	Floor noise
Hori	7320.000	AV	32.3	36.3	7.8	34.1	-	42.3	53.9	11.6	Floor noise
Hori	9760.000	AV	32.9	38.5	8.6	34.8	-	45.2	53.9	8.7	Floor noise
Vert	50.000	QP	22.9	10.3	7.4	32.2	-	8.4	40.0	31.6	
Vert	80.000	QP	22.6	6.3	7.8	32.2	-	4.5	40.0	35.5	
Vert	150.000	QP	22.2	14.8	8.6	32.1	-	13.5	43.5	30.0	
Vert	250.000	QP	22.0	12.5	9.5	32.0	-	12.0	46.0	34.0	
Vert	550.000	QP	22.0	18.4	11.6	32.0	-	20.0	46.0	26.0	
Vert	800.000	QP	21.9	20.8	13.0	31.5	-	24.2	46.0	21.8	
Vert	4880.000	PK	43.0	31.7	6.5	34.1	-	47.1	73.9	26.8	Floor noise
Vert	7320.000	PK	42.0	36.3	7.8	34.1	-	52.0	73.9	21.9	Floor noise
Vert	9760.000	PK	41.7	38.5	8.6	34.8	-	54.0	73.9	19.9	Floor noise
Vert	4880.000	AV	33.5	31.7	6.5	34.1	-	37.6	53.9	16.3	Floor noise
Vert	7320.000	AV	32.5	36.3	7.8	34.1	-	42.5	53.9	11.4	Floor noise
Vert	9760.000	AV	32.8	38.5	8.6	34.8	-	45.1	53.9	8.8	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.75 m / 3.0 m) = 1.94 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

Radiated Spurious Emission

Test place	Ise EMC Lab.	
Semi Anechoic Chamber	No.3	No.2
Report No.	11496304H	
Date	October 22, 2016	October 23, 2016
Temperature / Humidity	23 deg. C / 64 % RH	23 deg. C / 50 % RH
Engineer	Tomoki Matsui	Koji Yamamoto
	(Below 1 GHz and Above 10 GHz)	(1 GHz - 10 GHz)
Mode	Tx BT LE 2480 MHz	

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	50.000	QP	22.9	10.3	7.4	32.2	-	8.4	40.0	31.6	
Hori	80.000	QP	22.6	6.3	7.8	32.2	-	4.5	40.0	35.5	
Hori	150.000	QP	22.2	14.8	8.6	32.1	-	13.5	43.5	30.0	
Hori	250.000	QP	22.0	12.5	9.5	32.0	-	12.0	46.0	34.0	
Hori	550.000	QP	22.0	18.4	11.6	32.0	-	20.0	46.0	26.0	
Hori	800.000	QP	21.9	20.8	13.0	31.5	-	24.2	46.0	21.8	
Hori	2483.500	PK	47.9	27.7	5.1	34.7	-	46.0	73.9	27.9	
Hori	4960.000	PK	42.2	32.0	6.6	34.2	-	46.6	73.9	27.3	Floor noise
Hori	7440.000	PK	42.4	36.4	7.9	34.1	-	52.6	73.9	21.3	Floor noise
Hori	9920.000	PK	42.0	38.6	8.7	34.9	-	54.4	73.9	19.5	Floor noise
Hori	2483.500	AV	37.2	27.7	5.1	34.7	1.2	36.5	53.9	17.4	*1)
Hori	4960.000	AV	33.5	32.0	6.6	34.2	-	37.9	53.9	16.0	Floor noise
Hori	7440.000	AV	33.8	36.4	7.9	34.1	-	44.0	53.9	9.9	Floor noise
Hori	9920.000	AV	33.8	38.6	8.7	34.9	-	46.2	53.9	7.7	Floor noise
Vert	50.000	QP	22.9	10.3	7.4	32.2	-	8.4	40.0	31.6	
Vert	80.000	QP	22.6	6.3	7.8	32.2	-	4.5	40.0	35.5	
Vert	150.000	QP	22.2	14.8	8.6	32.1	-	13.5	43.5	30.0	
Vert	250.000	QP	22.0	12.5	9.5	32.0	-	12.0	46.0	34.0	
Vert	550.000	QP	22.0	18.4	11.6	32.0	-	20.0	46.0	26.0	
Vert	800.000	QP	21.9	20.8	13.0	31.5	-	24.2	46.0	21.8	
Vert	2483.500	PK	47.3	27.7	5.1	34.7	-	45.4	73.9	28.5	
Vert	4960.000	PK	42.3	32.0	6.6	34.2	-	46.7	73.9	27.2	Floor noise
Vert	7440.000	PK	42.8	36.4	7.9	34.1	-	53.0	73.9	20.9	Floor noise
Vert	9920.000	PK	43.4	38.6	8.7	34.9	-	55.8	73.9	18.1	Floor noise
Vert	2483.500	AV	37.5	27.7	5.1	34.7	1.2	36.8	53.9	17.1	*1)
Vert	4960.000	AV	33.4	32.0	6.6	34.2	-	37.8	53.9	16.1	Floor noise
Vert	7440.000	AV	33.6	36.4	7.9	34.1	-	43.8	53.9	10.1	Floor noise
Vert	9920.000	AV	34.3	38.6	8.7	34.9	-	46.7	53.9	7.2	Floor noise

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier) + Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (3.75 m / 3.0 m) = 1.94 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

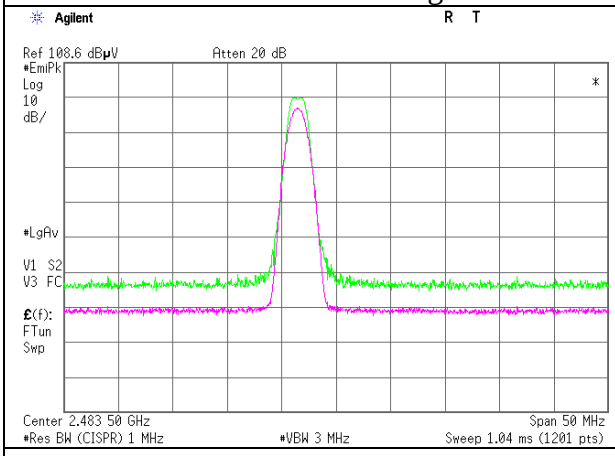
*1) Not Out of Band emission(Leakage Power)

Radiated Spurious Emission
(Reference Plot for band-edge)

Test place	Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No.	11496304H
Date	October 23, 2016
Temperature / Humidity	23 deg. C / 50 % RH
Engineer	Koji Yamamoto
	(1 GHz - 10 GHz)
Mode	Tx BT LE 2480 MHz

Horizontal

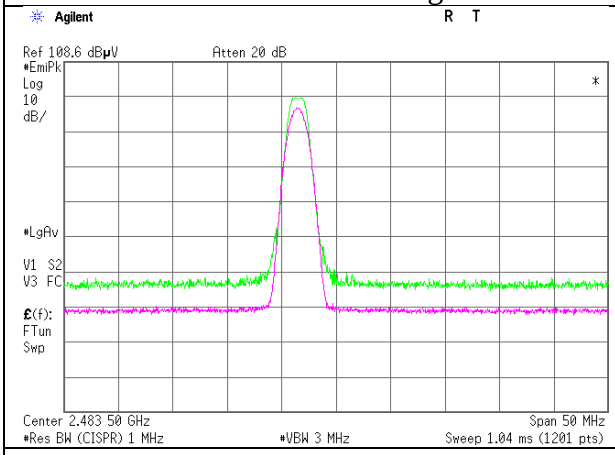
Restricted-band band-edge Plot



Trace Green : Peak Plot
Trace Purple : Average Plot

Vertical

Restricted-band band-edge Plot

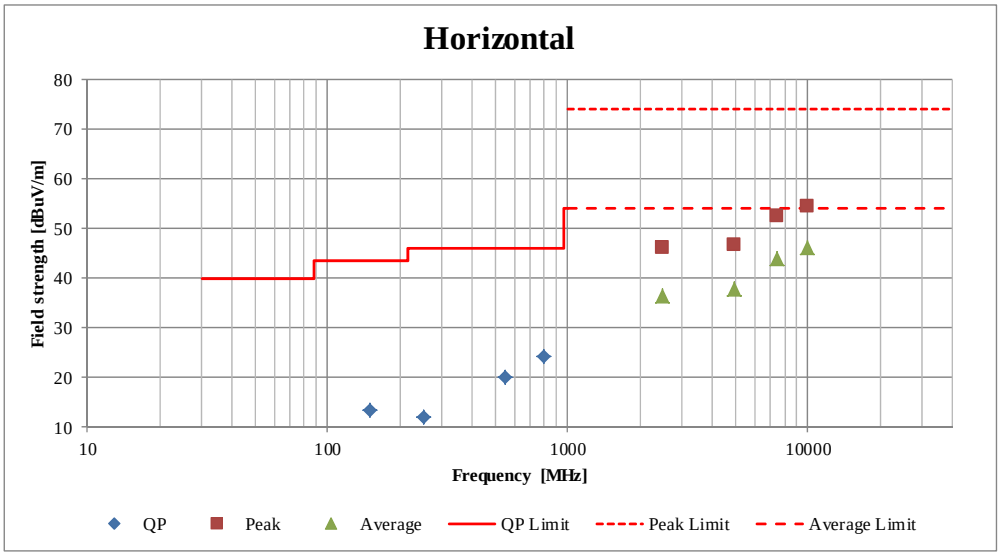


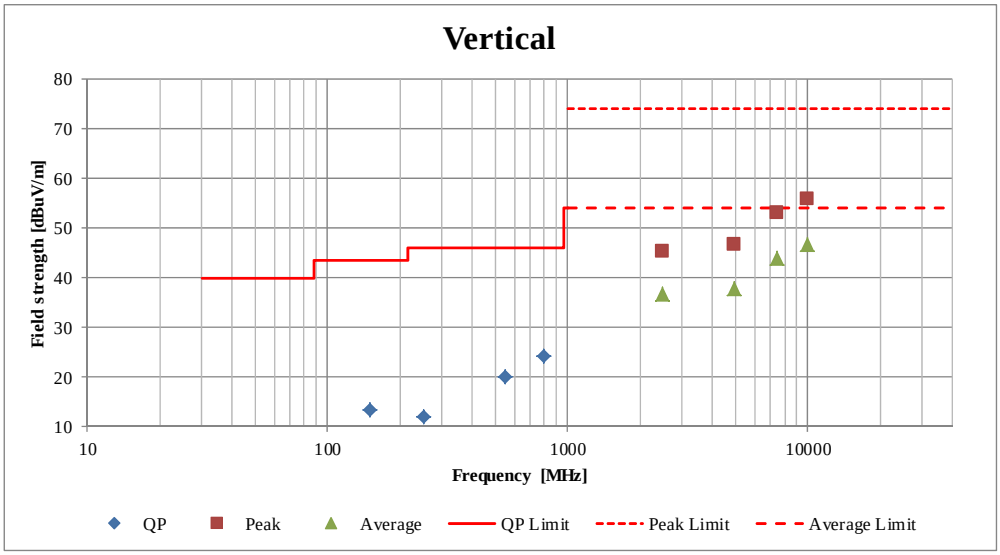
Trace Green : Peak Plot
Trace Purple : Average Plot

* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission
(Plot data, Worst case)

Test place	Ise EMC Lab. No.2 and No.3 Semi Anechoic Chamber	
Report No.	11496304H	
Date	October 22, 2016	October 23, 2016
Temperature / Humidity	23 deg. C / 64 % RH	23 deg. C / 50 % RH
Engineer	Tomoki Matsui	Koji Yamamoto
	(Below 1 GHz)	(1 GHz - 10 GHz)
	(Above 10 GHz)	
Mode	Tx BT LE 2480 MHz	





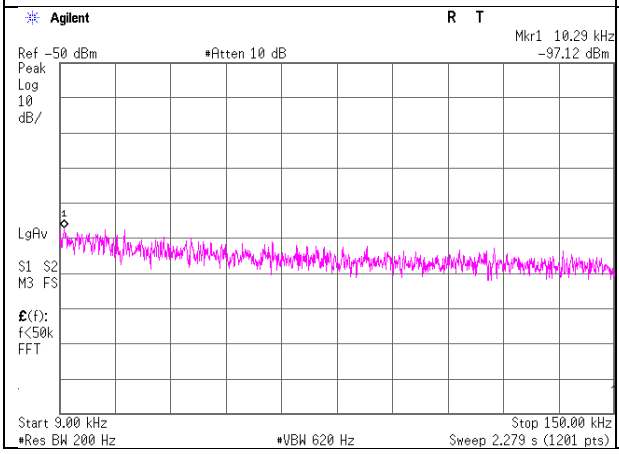
*These plots data contains sufficient number to show the trend of characteristic features for EUT.

UL Japan, Inc.
Ise EMC Lab.
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8999
Facsimile : +81 596 24 8124

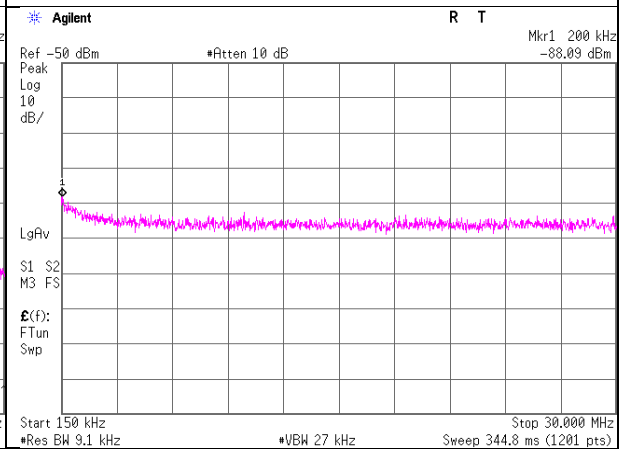
Conducted Spurious Emission

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE 2402 MHz

9 kHz - 150 kHz



150 kHz - 30 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
10.29	-97.1	0.01	9.8	2.0	1	-85.3	300	6.0	-24.0	47.3	71.3	
200.00	-88.1	0.01	9.8	2.0	1	-76.2	300	6.0	-15.0	21.5	36.5	

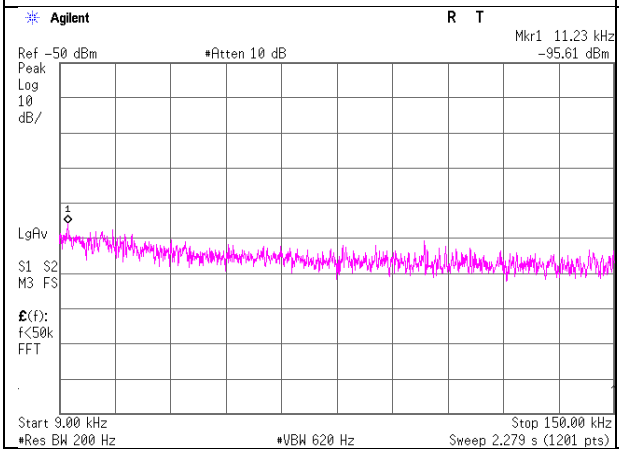
E = EIRP - 20 log (D) + Ground bounce + 104.8 [dBuV/m]

EIRP = Reading + Cable Loss + Attenator Loss + Antenna Gain + 10 * log (N)

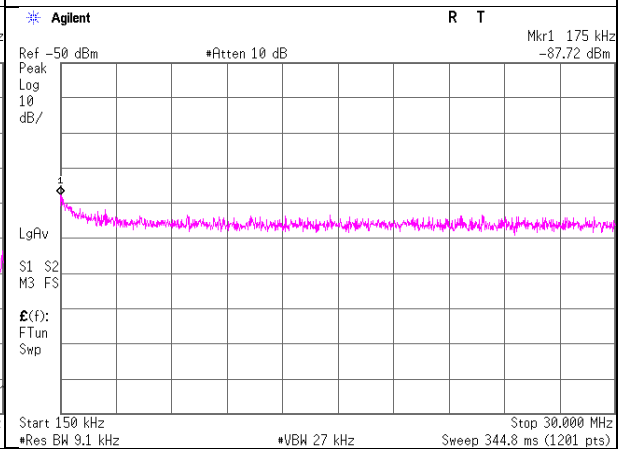
Conducted Spurious Emission

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE 2440 MHz

9 kHz - 150 kHz



150 kHz - 30 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
11.23	-95.6	0.01	9.8	2.0	1	-83.8	300	6.0	-22.5	46.5	69.0	
175.00	-87.7	0.01	9.8	2.0	1	-75.9	300	6.0	-14.6	22.7	37.3	

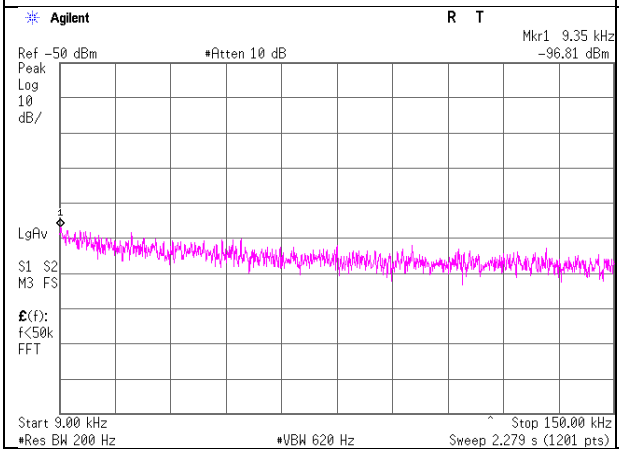
E = EIRP - 20 log (D) + Ground bounce + 104.8 [dBuV/m]

EIRP = Reading + Cable Loss + Attenator Loss + Antenna Gain + 10 * log (N)

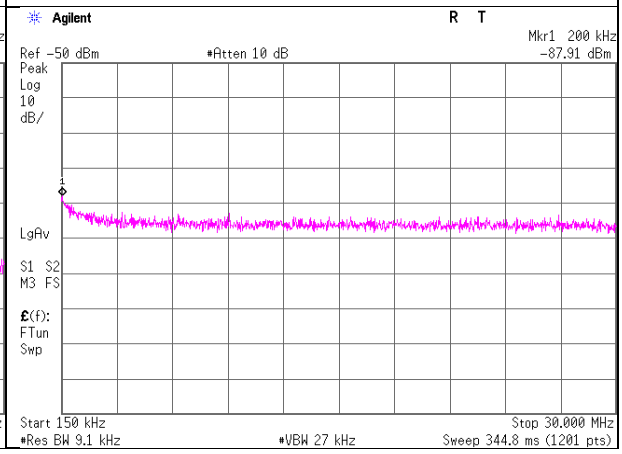
Conducted Spurious Emission

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE 2480 MHz

9 kHz - 150 kHz



150 kHz - 30 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenator Loss [dB]	Antenna Gain [dBi]	N (Number of Output	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
9.35	-96.8	0.01	9.8	2.0	1	-85.0	300	6.0	-23.7	48.1	71.8	
200.00	-87.9	0.01	9.8	2.0	1	-76.1	300	6.0	-14.8	21.5	36.3	

E = EIRP - 20 log (D) + Ground bounce + 104.8 [dBuV/m]

EIRP = Reading + Cable Loss + Attenator Loss + Antenna Gain + 10 * log (N)

Power Density

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE

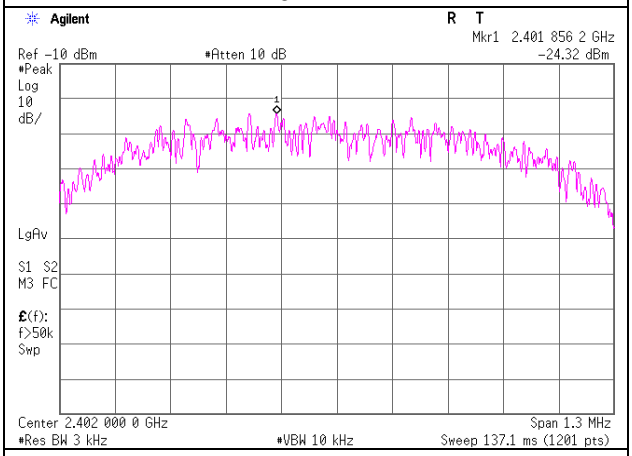
Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2402.00	-24.32	1.22	10.09	-13.01	8.00	21.01
2440.00	-24.15	1.23	10.09	-12.83	8.00	20.83
2480.00	-23.64	1.24	10.09	-12.31	8.00	20.31

Sample Calculation:
Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

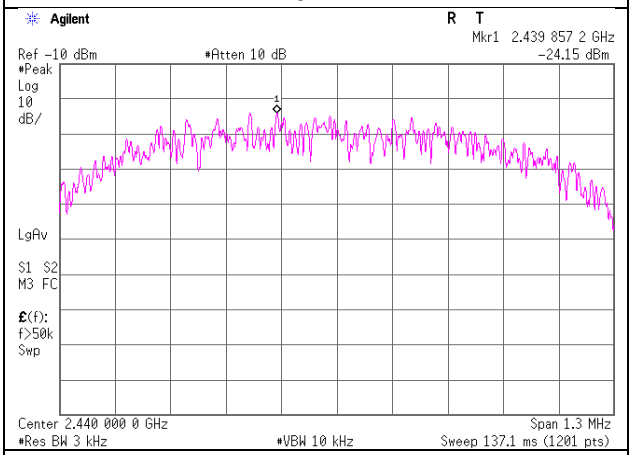
Power Density

BT LE

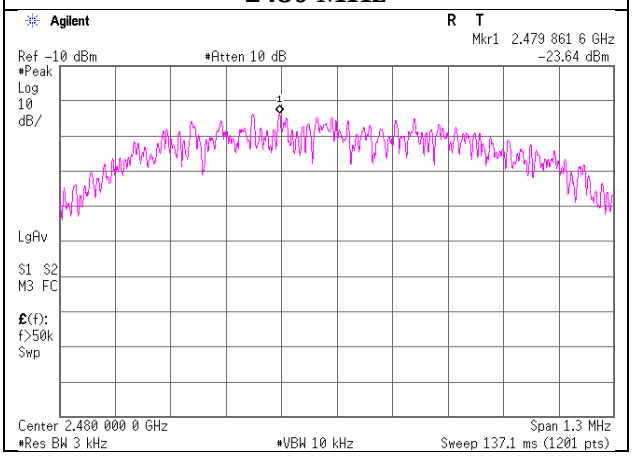
2402 MHz



2440 MHz



2480 MHz

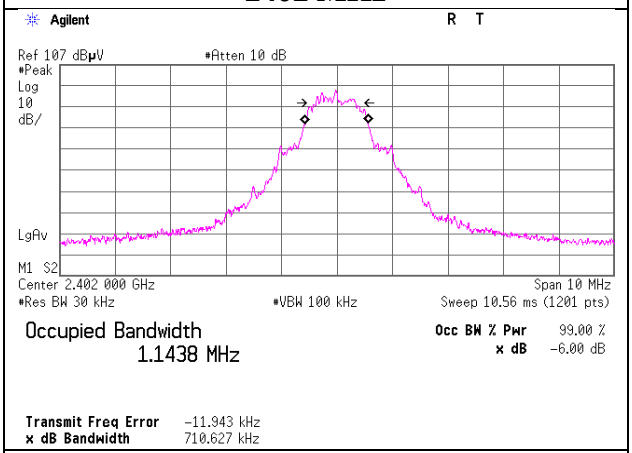


99%Occupied Bandwidth

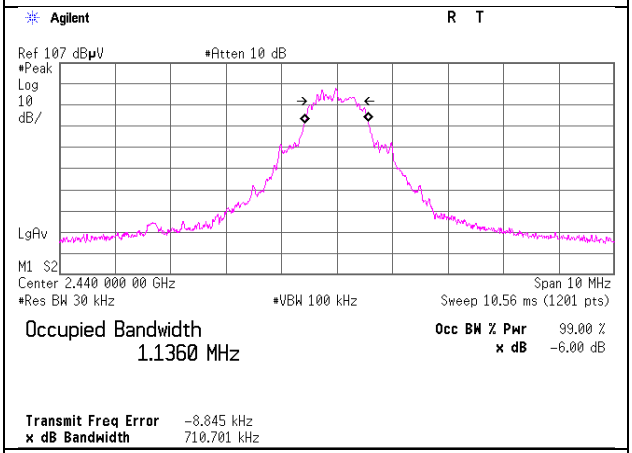
Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11496304H
Date	October 21, 2016
Temperature / Humidity	23 deg. C / 40 % RH
Engineer	Keisuke Kawamura
Mode	Tx BT LE

BT LE

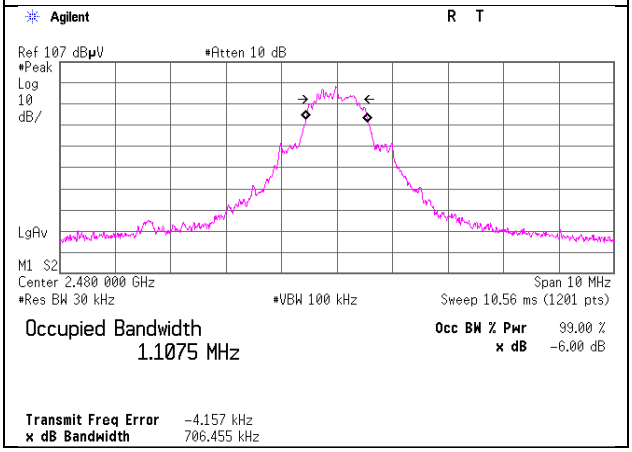
2402 MHz



2440 MHz



2480 MHz



APPENDIX 2: Test instruments

Test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE/CE	2016/10/20 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	1301	RE/CE	2016/01/21 * 12
MJM-16	Measure	KOMELON	KMC-36	-	RE/CE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE/CE	-
MSA-14	Spectrum Analyzer	Agilent	E4440A	MY48250080	RE/CE	2016/10/14 * 12
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE/CE	2016/09/15 * 12
MBA-03	Biconical Antenna	Schwarzbeck	BBA9106	1915	RE	2016/10/15 * 12
MLA-22	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-191	RE	2016/01/30 * 12
MCC-51	Coaxial cable	UL Japan	-	-	RE	2016/07/26 * 12
MAT-70	Attenuator(6dB)	Agilent	8491A-006	MY52460153	RE	2016/04/05 * 12
MPA-13	Pre Amplifier	SONOMA INSTRUMENT	310	260834	RE	2016/03/24 * 12
MMM-08	DIGITAL HiTESTER	Hioki	3805	051201197	RE	2016/01/13 * 12
MHA-20	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	RE	2016/05/29 * 12
MCC-167	Microwave Cable	Junkosha	MWX221	1404S374(1m) / 1405S074(5m)	RE	2016/05/20 * 12
MPA-11	MicroWave System Amplifier	Agilent	83017A	MY39500779	RE	2016/03/24 * 12
MHA-16	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170306	RE	2016/05/29 * 12
MHF-25	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	001	RE	2016/09/21 * 12
MLS-24	LISN(AMN)	Schwarzbeck	NSLK8127	8127-730	CE(EUT)	2016/07/11 * 12
MCC-112	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W(10m)/ SFM141(3m)/ sucoform141-PE(1m)/ 421-010(1.5m)/ RFM-E321(Switcher)	-/00640	CE	2016/07/26 * 12
MAT-66	Attenuator(13dB)	JFW Industries, Inc.	50FP-013H2 N	-	CE	2016/01/14 * 12
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	RE	2016/08/02 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	RE	2016/01/21 * 12
MJM-14	Measure	KOMELON	KMC-36	-	RE	-
MSA-03	Spectrum Analyzer	Agilent	E4448A	MY44020357	RE	2016/05/19 * 12
MHA-06	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	254	RE	2016/02/29 * 12
MCC-216	Microwave Cable	Junkosha	MWX221	1604S253(1 m) / 1608S087(5 m)	RE	2016/08/29 * 12
MPA-10	Pre Amplifier	Agilent	8449B	3008A02142	RE	2016/01/19 * 12
MMM-01	Digital Tester	Fluke	FLUKE 26-3	78030611	RE	2016/08/23 * 12
MHF-26	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	002	RE	2016/09/19 * 12
MOS-19	Thermo-Hygrometer	Custom	CTH-201	0001	AT	2015/12/08 * 12
MCC-170	Microwave Cable	Junkosha	MWX221	1409S493	AT	2016/03/11 * 12
MAT-23	Attenuator(10dB) 1-18GHz	Orient Microwave	BX10-0476-00	-	AT	2016/03/18 * 12
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	AT	2015/11/06 * 12
MPM-13	Power Meter	Anritsu	ML2495A	0824014	AT	2015/11/11 * 12
MPSE-18	Power sensor	Anritsu	MA2411B	0738174	AT	2015/11/11 * 12
MAT-10	Attenuator(10dB)	Weinschel Corp	2	BL1173	AT	2015/11/10 * 12
MCC-64	Coaxial Cable	UL Japan	-	-	AT	2016/03/10 * 12

The expiration date of the calibration is the end of the expired month.
All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item: **CE: Conducted Emission test**
RE: Radiated Emission test
AT: Antenna Terminal Conducted test